Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/618,019	UNNO ET AL.
Examiner	Art Unit
Y. Lee	2621

	SEAR	CHED	
Class	Subclass	Date	Examiner
348	148 <b>**</b> 151	4/11/2007	YL
250	330		
H04N	7/18		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

DATE	GY)